



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants : Akira GYOTOKU et al.

Group Art Unit : 2852

Appl. No. : 10/726,594

Examiner : Not Yet Assigned

Filed : December 4, 2003

Confirmation No. : 6999

For : IMAGE FORMING APPARATUS

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
220 20th Street S.
Customer Window, Mail Stop _____
Crystal Plaza Two, Lobby, Room 1B03
Arlington, VA 22202

Sir :

In accordance with the duty of disclosure under 37 C.F.R. §1.56 and §§1.97-1.98 and supplemental to the Information Disclosure Statements that were filed on June 25, 2004 and March 18, 2004, Applicants hereby submit a copy of an International Search Report that was mailed on September 30, 2004, with respect to patent family member International Patent Application No. PCT/JP03/15616, in which the following documents were cited:

- (1) Japanese Laid-Open Patent Publication No. 2001-063136, together with an English language Abstract of the same;
- (2) European Patent Application Publication No. EP 0 916 506;
- (3) European Patent Application Publication No. EP 0 550 190;
- (4) U.S. Patent No. 5,751,327;

- (5) U.S. Patent No. 6,121,995;
- (6) U.S. Patent No. 6,012,291;
- (7) U.S. Patent No. 6,121,994;
- (8) International Patent Application Publication No. WO 02/15645;
- (9) S. LAMANSKY et al., Journal of Applied Physics, Vol. 92, No. 3, August 1, 2002, pp. 1570-1575;
- (10) C. ADACHI et al., Applied Physics Letters, Vol. 78, No. 11, March 12, 2001, pp. 1622-1624;
- (11) European Patent Application Publication No. 0 731 625; and
- (12) R.C. KWONG et al., Advanced Materials, Vol. 12, No. 15, August 2, 2000, pp. 1134-1138.

The category of relevance, pertinent portions, and claims to which each document is relevant, as ascertained by the European Examiner applying appropriate rules to the International claims are set forth in the International Search Report.

Applicants note that documents (1)-(6) were previously cited to the Examiner, and thus copies of these documents are not being provided herewith.

Further to the U.S. Patent and Trademark Office's decision to waive the requirement under 37 C.F.R. §1.98 (a)(2)(i), copies of the U.S. patents are not enclosed herewith. However, if any copies are needed, the Examiner is respectfully requested to contact the undersigned.

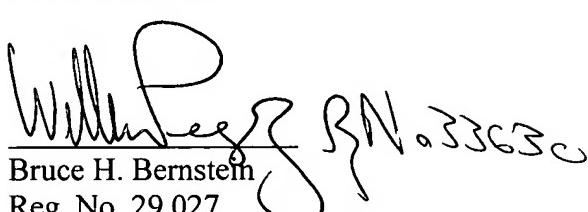
Applicant respectfully requests that the Examiner consider the above material and cite the same. Copies of documents (8)-(12) are attached hereto and all of the documents are listed on the attached PTO-1449 Form. The Examiner is requested to initial the

appropriate spaces on the attached Form and to return a copy of the completed Form to Applicants with the next official communication in the present application.

Applicants note that an Office Action on the merits has not issued in the present application, and thus no fee is believed necessary to ensure consideration of the submitted material.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully Submitted,
Akira GYOTOKU et al.

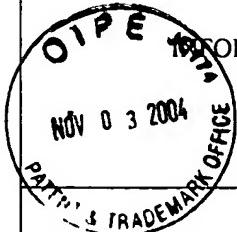

Bruce H. Bernstein
Reg. No. 29,027

November 2, 2004
GREENBLUM & BERNSTEIN, P.L.C.
1950 Roland Clarke Place
Reston, VA 20191
(703) 716-1191

**U.S. Department of Commerce
Patent and Trademark Office**

Atty. Docket No.
P24651

Application No.
10/726,594



**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**
(Use several sheets if necessary)

Applicant
Akira GYOTOKU et al.

Filing Date	Group
December 04, 2003	2852

U.S. PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

		1 English language Abstract of JP 2001-063136.
		2 S. LAMANSKY et al., Journal of Applied Physics, Vol. 92, No. 3, August 1, 2002, pp. 1570-1575.
		3 C. ADACHI et al., Applied Physics Letters, Vol. 78, No. 11, March 12, 2001, pp. 1622-1624.
		4 R.C. KWONG et al., Advanced Materials, Vol. 12, No. 15, August 2, 2000, pp. 1134-1138.

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.